

April 2001

Si3447DV

P-Channel 1.8V Specified PowerTrench® MOSFET

General Description

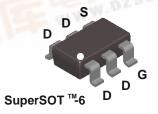
This P-Channel 1.8V specified MOSFET uses Fairchild's low voltage PowerTrench process. It has been optimized for battery power management applications.

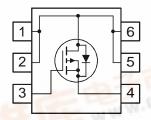
Applications

- Battery management
- Load switch
- Battery protection

Features

- -5.5 A, -20 V. $R_{DS(ON)} = 33 \ m\Omega \ @ \ V_{GS} = -4.5 \ V$ $R_{DS(ON)} = 43 \ m\Omega \ @ \ V_{GS} = -2.5 \ V$ $R_{DS(ON)} = 60 \ m\Omega \ @ \ V_{GS} = -1.8 \ V$
- Fast switching speed.
- High performance trench technology for extremely low R_{DS(ON)}





Absolute Maximum Ratings TA=25°C unless otherwise noted

| Symbol | Parameter | M | Ratings | Units |
|-----------------------------------|--|-----------|-------------|-------|
| V _{DSS} | Drain-Source Voltage | | -20 | V |
| V _{GSS} | Gate-Source Voltage | | ±8 | V |
| I _D | Drain Current - Continuous | (Note 1a) | -5.5 | Α |
| | – Pulsed | | -20 | 15 |
| P _D | Maximum Power Dissipation | (Note 1a) | 1.6 | W |
| | | (Note 1b) | 0.8 | IV C |
| T _J , T _{STG} | Operating and Storage Junction Temperature Range | | −55 to +150 | °C |

Thermal Characteristics

| $R_{\theta JA}$ | Thermal Resistance, Junction-to-Ambient | (Note 1a) | 78 | °C/W |
|------------------|---|-----------|----|------|
| R _{θJC} | Thermal Resistance, Junction-to-Case | (Note 1) | 30 | °C/W |

Package Marking and Ordering Information

| Device Marking | Device | Reel Size | Tape width | Quantity |
|----------------|----------|-----------|------------|------------|
| .447 | Si3447DV | 7" | 8mm | 3000 units |

| Symbol | Parameter | Test Conditions | Min | Тур | Max | Units |
|--|---|---|------|----------------|----------------|-------|
| Off Char | acteristics | | | | I | |
| BV _{DSS} | Drain-Source Breakdown Voltage | $V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$ | -20 | | | V |
| ΔBV _{DSS} ΔT _J | Breakdown Voltage Temperature Coefficient | $I_D = -250 \mu\text{A}$, Referenced to 25°C | | -12 | | mV/°C |
| I _{DSS} | Zero Gate Voltage Drain Current | $V_{DS} = -16 \text{ V}, V_{GS} = 0 \text{ V}$ | | | -1 | μΑ |
| I _{GSSF} | Gate-Body Leakage, Forward | $V_{GS} = 8 \text{ V}, \qquad V_{DS} = 0 \text{ V}$ | | | 100 | nA |
| I _{GSSR} | Gate-Body Leakage, Reverse | $V_{GS} = -8 \text{ V}$ $V_{DS} = 0 \text{ V}$ | | | -100 | nA |
| On Char | acteristics (Note 2) | | | | | |
| $V_{GS(th)}$ | Gate Threshold Voltage | $V_{DS} = V_{GS}, I_{D} = -250 \ \mu A$ | -0.4 | -0.7 | -1.5 | V |
| $\frac{\Delta V_{GS(th)}}{\Delta T_J}$ | Gate Threshold Voltage Temperature Coefficient | $I_D = -250 \mu\text{A}, \text{Referenced to } 25^{\circ}\text{C}$ | | 3 | | mV/°C |
| R _{DS(on)} | Static Drain–Source On–Resistance | V _{GS} = -4.5 V, I _D = -5.5 A V _{GS} = -2.5 V, I _D = -4.8 A V _{GS} = -1.8 V, I _D = -4.0 A | | 24 30 42 | 33 43 60 | mΩ |
| I _{D(on)} | On-State Drain Current | $V_{GS} = -4.5 \text{ V}, \qquad V_{DS} = -5 \text{ V}$ | -20 | | | Α |
| g _{FS} | Forward Transconductance | $V_{DS} = -5 \text{ V}, \qquad I_{D} = -3.5 \text{ A}$ | | 23 | | S |
| Dynamic | Characteristics | | | | • | |
| C _{iss} | Input Capacitance | $V_{DS} = -10 \text{ V}, V_{GS} = 0 \text{ V},$ | | 1926 | | pF |
| Coss | Output Capacitance | f = 1.0 MHz | | 530 | | pF |
| C _{rss} | Reverse Transfer Capacitance | 7 | | 185 | | pF |
| Switchin | g Characteristics (Note 2) | | | | | |
| t _{d(on)} | Turn-On Delay Time | $V_{DD} = -10 \text{ V}, \qquad I_D = -1 \text{ A},$ | | 13 | 23 | ns |
| t _r | Turn-On Rise Time | $V_{GS} = -4.5 \text{ V}, \qquad R_{GEN} = 6 \Omega$ | | 11 | 20 | ns |
| t _{d(off)} | Turn-Off Delay Time | 7 | | 90 | 144 | ns |
| t _f | Turn-Off Fall Time | 7 | | 45 | 72 | ns |
| Q_g | Total Gate Charge | $V_{DS} = -10 \text{ V}, \qquad I_{D} = -3.5 \text{ A},$ | | 19 | 30 | nC |
| Q _{gs} | Gate-Source Charge | $V_{GS} = -4.5 \text{ V}$ | | 4 | | nC |
| Q_{gd} | Gate-Drain Charge | | | 7.5 | | nC |
| Drain-S | ource Diode Characteristics | and Maximum Ratings | | | | |
| Is | Maximum Continuous Drain-Source | | | | -1.3 | Α |
| V _{SD} | Drain-Source Diode Forward Voltage | $V_{GS} = 0 \text{ V}, I_S = -1.3 \text{ A} \text{(Note 2)}$ | | -0.7 | -1.2 | V |

Notes:

- a. 78°C/W when mounted on a 1in² pad of 2oz copper on FR-4 board.
- b. 156°C/W when mounted on a minimum pad.
- 2. Pulse Test: Pulse Width \leq 300 μ s, Duty Cycle \leq 2.0%

^{1.} $R_{\theta JA}$ is the sum of the junction-to-case and case-to-ambient resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. $R_{\theta JC}$ is guaranteed by design while $R_{\theta CA}$ is determined by the user's board design.

Typical Characteristics

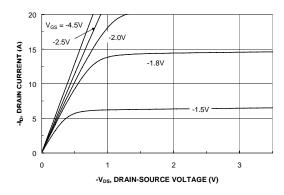


Figure 1. On-Region Characteristics.

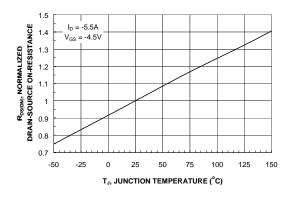


Figure 3. On-Resistance Variation withTemperature.

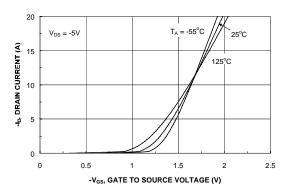


Figure 5. Transfer Characteristics.

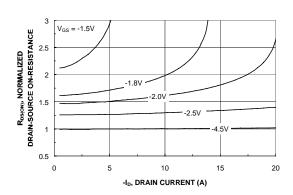


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

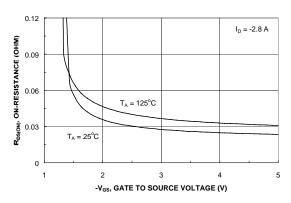


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

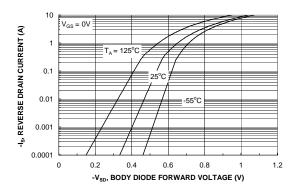
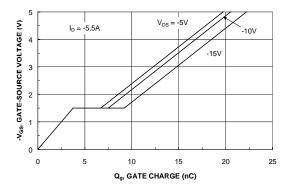


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

Typical Characteristics



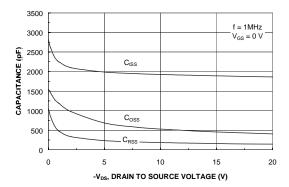


Figure 7. Gate Charge Characteristics.

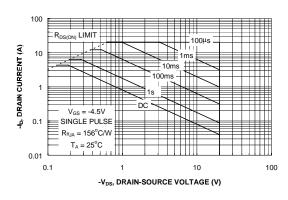


Figure 8. Capacitance Characteristics.

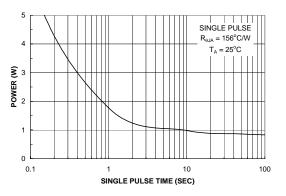


Figure 9. Maximum Safe Operating Area.



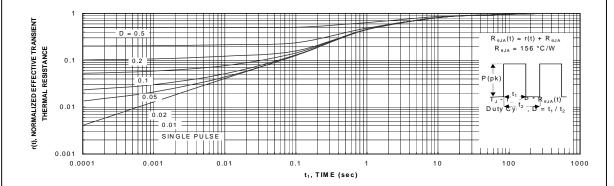


Figure 11. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1b. Transient thermal response will change depending on the circuit board design.

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| DenseTrench™ | HiSeC™ | QS™ | TinyLogic™ |
| DOME™ | ISOPLANAR™ | QT Optoelectronics™ | UHC TM |
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